

Search Notes



Application/Control No.

09/764,756

Examiner

HUY T. NGUYEN

Applicant(s)/Patent under
Reexamination

TZOU, HON-DER

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
386	46	6/24/05 br	
	95		
125			
126			
84	609		
725	100		4
↓	105	4	br

SEARCH NOTES
(INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Fast search US PGPUB US PAT, US OCR, EPO JPO, DERVENT, IBM (see printout)	6/24/05 br	
	5/21/05 br	

INTERFERENCE SEARCHED

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